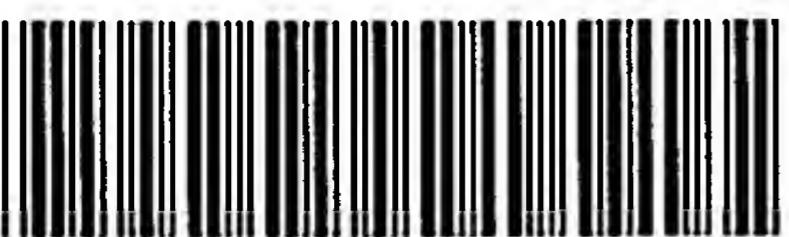


Search Notes



Application/Control No.

10/010.646

Examiner

Andrew Hwa S. Lee

**Applicant(s)/Patent under
Reexamination**

HAN ET AL.

Art Unit

2877

SEARCHED

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner